Application No.	Applicant(s)	
10/035,547	WU, YUAN-HSUN	
Examiner	Art Unit	
Δlan Δ Mathews	2851	

SEARCHED				
OLANOILE D				
Class	Subclass	Date	Examiner	
356	237.2 237.3 237.4 237.5	6/14/2004	АМ	
430	5	6/14/2004	AM	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
356	237.3	6/14/2004	АМ	
356	237.4	6/14/2004	AM	
430	5	6/14/2004	АМ	

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
(356/237.3,237.4,237.5.ccls. or 430/5.ccls.) and (mask or reticle) and defect\$4 and ratio\$4	6/14/2004	AM
(356/237.3,237.4,237.5.ccls. or 430/5.ccls.) and (mask or reticle) and defect\$4 and repair	6/14/2004	АМ